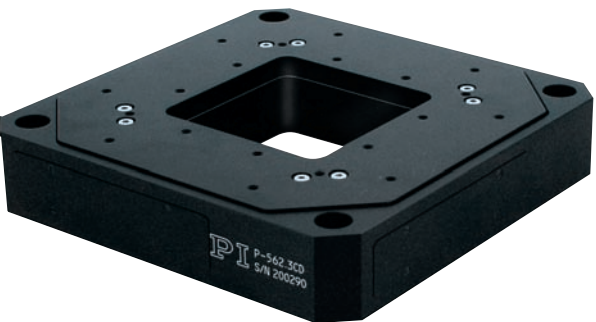


PIMars™ XYZ Stage with Piezo Flexure Drive

High-Precision Nanopositioning Stage, 3 to 6 Axes



P-562 PIMars™ multi-axis, parallel-kinematics nanopositioning stages are available with up to 340 µm travel per axis. Custom versions to 6 DOF are available

- Parallel-Kinematics / Metrology for Enhanced Responsiveness / Multi-Axis Precision
- Travel Ranges to 340 x 340 x 340 µm
- Capacitive Sensors for Highest Linearity
- Frictionless, High-Precision Flexure Guiding System
- Excellent Scanning Flatness
- High-Dynamics XYZ Version Available; Custom Versions to 6-DOF
- Clear Aperture 66 x 66 mm
- Outstanding Lifetime Due to PICMA® Piezo Actuators
- UHV Versions to 10⁻⁹ hPa

PIMars™ open-frame piezo stages are fast and highly accurate multi-axis scanning and nanopositioning systems with flatness and straightness in the nanometer range.

The 66 x 66 mm clear aperture is ideal for transmitted-light applications such as near-field scanning or confocal microscopy and mask positioning.

Large Variety of Models

PIMars™ multi-axis nanopositioners are offered in a large

Application Examples

- Scanning microscopy
- Mask/wafer positioning
- Interferometry
- Metrology
- Biotechnology
- Micromanipulation

variety of configurations. Standard models include long-travel systems (to 300 x 300 x 300 µm), high-speed and vacuum versions. Custom six-axis designs with rotation to 6 mrad are available on request.

PI offers versions specially designed for applications in ultra-high vacuum with vacuum-qualified components only. The integrated ceramic-encapsulated PICMA® actuators allow high bakeout temperatures and assure minimal outgassing rates. A non-magnetizable version is available on request.

Direct Drive for Ultra-Fast Scanning and Positioning

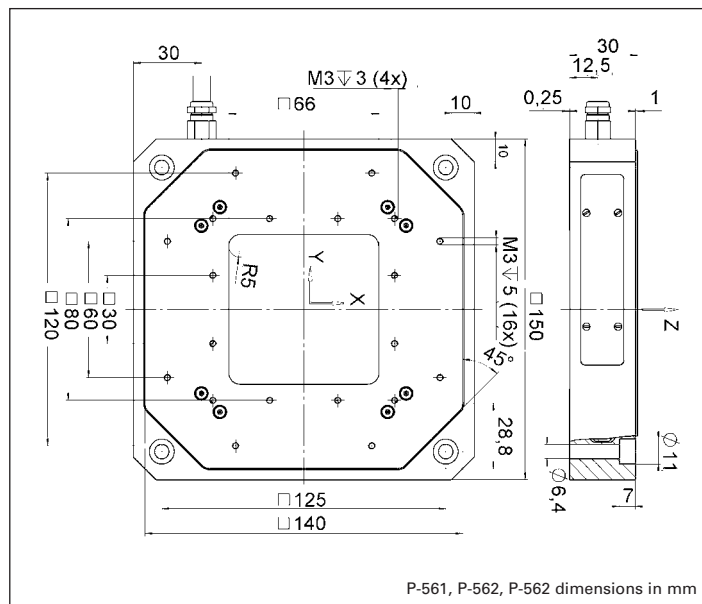
The P-561.3DD versions have resonant frequencies to 1.0 kHz, enabling millisecond scanning rates with sub-nanometer resolution.

Capacitive Sensors for Highest Accuracy and Position Stability

PI's proprietary capacitive sensors measure position directly and without physical contact. They are free of friction and hysteresis, a fact which, in combination with the positioning resolution of well under 1 nm, makes it possible to achieve very high levels of linearity. A further advantage of direct metrology with capacitive sensors is the high phase fidelity and the high bandwidth of up to 10 kHz.

Active and Passive Guidance for Nanometer Flatness and Straightness

Wire-cut flexures optimized with Finite Element Analysis (FEA) are used to guide the stage. The FEA techniques give the design the highest possible stiffness and minimize linear and angular runout. Further enhancement is achieved by active trajectory control: multi

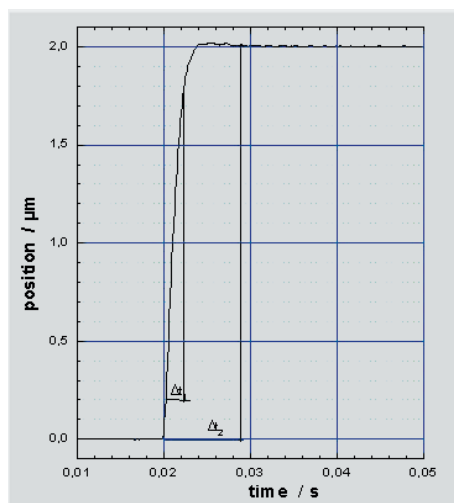


P-561, P-562, P-562 dimensions in mm

System properties

System Configuration	P-561.3CD with E-710 digital controller, 330 g load
Amplifier bandwidth, small signal	25 Hz in X, Y; 35 Hz in Z
Settling time (10% step)	20 ms

axis nanopositioning systems equipped with parallel metrology are able to measure platform position in all degrees of freedom against a common, fixed reference. In such systems, undesirable motion from one actuator in the direction of another (cross-talk) is detected immediately and actively compensated by the servo-loops. This can keep deviation from a trajectory to under a few nanometers, even in dynamic operation.



P-562.3CD (unloaded) step and settle is faster than 10 ms in X, Y and Z

Technical Data

Model	P-561.3CD	P-562.3CD	P-563.3CD	P-561.3DD	Units	Tolerance
Active axes	X, Y, Z	X, Y, Z	X, Y, Z	X, Y, Z		
Motion and positioning						
Integrated sensor	Capacitive	Capacitive	Capacitive	Capacitive		
Open-loop travel, -20 to +120 V	150 x 150 x 150	300 x 300 x 300	340 x 340 x 340	58 x 58 x 18	μm	min. (+20%/0%)
Closed-loop travel	100 x 100 x 100	200 x 200 x 200	300 x 300 x 300	45 x 45 x 15	μm	
Open-loop resolution	0.2	0.4	0.5	0.1	nm	typ.
Closed-loop resolution	0.8	1	2	0.2	nm	typ.
Linearity	0.03	0.03	0.03	0.01*	%	typ.
Repeatability in X, Y, Z	2 / 2 / 2	2 / 2 / 4	2 / 2 / 4	2 / 2 / 2	nm	typ.
Pitch in X,Y	±1	±2	±2	±3	μrad	typ.
Runout θ_x , θ_y (Z motion)	±15	±20	±25	±3	μrad	typ.
Yaw in X, Y	±6	±10	±10	±3	μrad	typ.
Flatness in X, Y	±15	±20	±25	±10	nm	typ.
Crosstalk X, Y (Z motion)	±30	±50	±50	±20	nm	typ.
Mechanical properties						
Unloaded resonant frequency in X / Y / Z	190 / 190 / 380	160 / 160 / 315	140 / 140 / 250	920 / 920 / 1050**	Hz	±20%
Resonant frequency @ 100 g in X / Y / Z	–	145 / 145 / 275	120 / 120 / 215	860 / 860 / 950	Hz	±20%
Resonant frequency @ 330 g in X / Y / Z	140 / 140 / 300	130 / 130 / 195	110 / 110 / 170	500 / 500 / 470	Hz	±20%
Push force capacity in motion direction in X / Y / Z	200 / 200 / 50	120 / 120 / 50	100 / 100 / 50	200 / 200 / 50	N	Max.
Pull force capacity in motion direction in X / Y / Z	30 / 30 / 30	30 / 30 / 30	30 / 30 / 30	30 / 30 / 30		
Load capacity	50	50	50	50	N	Max.
Drive properties						
Ceramic type	PICMA® P-885	PICMA® P-885	PICMA® P-885	PICMA® P-885 in Z, P-888 in XY		
Electrical capacitance in X / Y / Z	5.2 / 5.2 / 10.4	7.4 / 7.4 / 14.8	7.4 / 7.4 / 14.8	38 / 38 / 6	μF	±20%
Dynamic operating current coefficient (DOCC) in X / Y / Z	6.5 / 6.5 / 13	4.6 / 4.6 / 9.25	3.1 / 3.1 / 6.1	106 / 106 / 50	μA/ (Hz • μm)	±20%
Miscellaneous						
Operating temperature range	-20 to 80	-20 to 80	-20 to 80	-20 to 80	°C	
Material	Aluminum	Aluminum	Aluminum	Aluminum		
Mass	1.45	1.45	1.45	1.55	kg	±5%
Cable length	1.5	1.5	1.5	1.5	m	±10 mm
Sensor / voltage connection	Sub-D Special	Sub-D Special	Sub-D Special	Sub-D Special		

Resolution of PI Piezo Nanopositioners is not limited by friction or stiction. Value given is noise equivalent motion with E-710 (p. 2-128) controller.

*With digital controller. Non-linearity of direct drive stages measured with analog controllers is typically up to 0.1%.

Recommended controller

Multi-channel digital controllers: E-710 bench-top (p. 2-128), E-712 modular (p. 2-140), E-725 high-power (p. 2-126), E-761 PCI board (p. 2-130)